

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/774,535	LEE ET AL.
	Examiner	Art Unit
	Tung X. Le	2821
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0016195	01-2003	Sagano et al.	345/75.2
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	L	US-			
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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